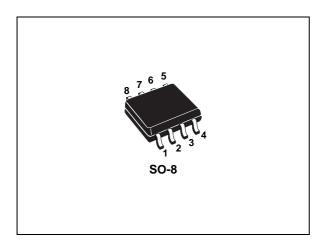
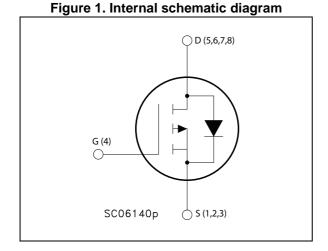


P-channel 60 V, 0.13 Ω typ., 3 A STripFETTM VI DeepGATETM Power MOSFET in a SO-8 package

Datasheet - production data





Features

Order code	V _{DSS}	R _{DS(on)max}	I _D
STN3P6F6	60 V	0.16 Ω @ 10 V	3 A

- R_{DS(on)} * Qg industry benchmark
- Extremely low on-resistance R_{DS(on)}
- · High avalanche ruggedness
- · Low gate drive power losses

Applications

• Switching applications

Description

This device is a P-channel Power MOSFET developed using the 6th generation of STripFETTM DeepGATETM technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest $R_{DS(on)}$ in all packages.

Table 1. Device summary

Order code	Marking	Package	Packaging
STS3P6F6	3K60	SO-8	Tape and reel

Note: For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

Contents STS3P6F6

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STS3P6F6 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	60	V
V _{GS}	Gate-source voltage	± 20	V
I _D	Drain current (continuous) at T _{pcb} = 25 °C	3	Α
I _D	Drain current (continuous) at T _{pcb} = 100 °C	2	Α
I _{DM}	Drain current (pulsed)	12	Α
P _{TOT} (1)	Total dissipation at T _{pcb} = 25 °C	2.7	W
T _j P _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

^{1.} Pulse width is limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit	
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb max	47	°C/W	İ

^{1.} When mounted on FR-4 board of 15 mm², 2 Oz Cu, t<10 sec

Note:

For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

Electrical characteristics STS3P6F6

2 Electrical characteristics

(Tcase = 25 °C unless otherwise specified).

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage (V _{GS} = 0)	I _D = 250 μA	60			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 60 V V _{DS} = 60 V, T _C =125 °C			1 10	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 1.5 A		0.13	0.16	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 48 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	340 40 20	-	pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 48 \text{ V}, I_D = 3 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 3</i>)	-	6.4 1.7 1.7	-	o o o

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$t_{ m d(on)}$ $t_{ m r}$ $t_{ m d(off)}$ $t_{ m f}$	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 48 \text{ V}, I_{D} = 1.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 2</i>)	-	6.4 5.3 14 3.7	-	ns ns ns ns

For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

Note:

Unit **Symbol Parameter Test conditions** Min. Тур. Max. I_{SD} Source-drain current 3 Α I_{SDM} (1) Source-drain current (pulsed) 12 Α V_{SD} (2) $I_{SD} = 3 A, V_{GS} = 0$ 1.1 ٧ Forward on voltage Reverse recovery time $I_{SD} = 5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ 20 t_{rr} ns \mathbf{Q}_{rr} $V_{DD} = 16 \text{ V}, T_j = 150 \text{ }^{\circ}\text{C}$ Reverse recovery charge 17.8 nC (see Figure 4) Reverse recovery current 1.8 Α I_{RRM}

Table 7. Source drain diode

- 1. Pulse width limited by safe operating area.
- 2. Pulse duration = 300 µs, duty cycle 1.5%

Note: For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.



Test circuits STS3P6F6

3 Test circuits

Figure 2. Switching times test circuit for resistive load

Figure 3. Gate charge test circuit

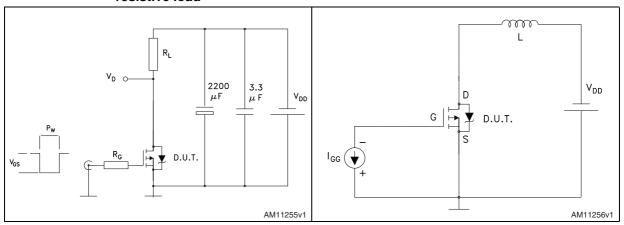
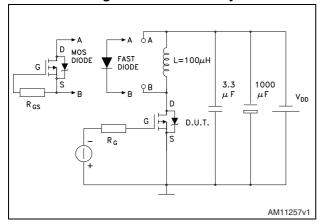


Figure 4. Test circuit for inductive load switching and diode recovery times



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



Table 8. SO-8 mechanical data

Table 6. 66-6 meenamear data				
Dim.		mm		
D	Min.	Тур.	Max.	
А			1.75	
A1	0.10		0.25	
A2	1.25			
b	0.31		0.51	
b1	0.28		0.48	
С	0.10		0.25	
c1	0.10		0.23	
D	4.80	4.90	5.00	
E	5.80	6.00	6.20	
E1	3.80	3.90	4.00	
е		1.27		
h	0.25		0.50	
L	0.40		1.27	
L1		1.04		
L2		0.25		
k	0°		8°	
ссс			0.10	

SEATING PLANE

BASE METAL

O016023_G_FU

Figure 5. SO-8 drawing

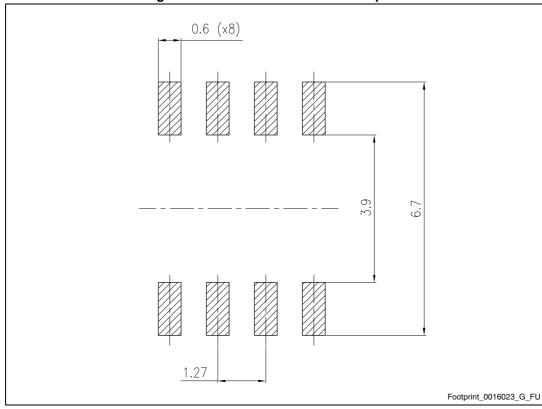


Figure 6. (a) SO-8 recommended footprint

a. All dimensions are in millimeters.

5 Packaging mechanical data

Table 9. SO-8 tape and reel mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α			330
С	12.8		13.2
D	20.2		
N	60		
Т			22.4
Ao	8.1		8.5
Во	5.5		5.9
Ko	2.1		2.3
Po	3.9		4.1
Р	7.9		8.1

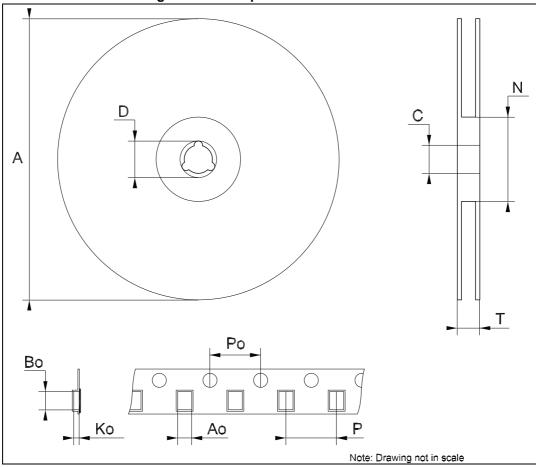


Figure 7. SO-8 tape and reel dimensions

STS3P6F6 Revision history

6 Revision history

Table 10. Document revision history

Date	Revision	Changes
22-Mar-2013	1	First release.

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